TCR MULTILAYER CHIP VARISTORS

# **PART NO.** MVR0603-180E500

## 1. Electrical Specification

#### 1-1 Test condition

Varistor voltage	In = 1 mA DC
Leakage current	Vdc = 18 V DC
Maximum clamping voltage	lc = 1 A
Rated peak single pulse transient current	8 / 20 $\mu$ s waveform, +/- each 1 time induce
Capacitance	10/1000 µs waveform
Insulation resistance after reflow soldering	f = 1MHz, Vrms = 0.5 V
Reflow soldering condition	Soldering paste : Tamura (Japan) RMA-20-21L Stencil : SUS, 120 $\mu$ m thickness Pad size : 0.8 (Width) x 0.9 (Length) 0.8 (Distance between pads) Soldering profile : 260 $\pm$ 5 °C, 5 sec.

#### 1-2 Electrical specification

Maximum allowable continuous DC voltage	18	V	
trigger voltage / Varistor voltage / breakdown voltage	22-28	V	
Maximum clamping voltage	45	V	Maximum
Rated peak single pulse transient current	1	А	Maximum
Nonlinearity coefficient	> 12		
Leakage current at continuous DC voltage	< 0.1	μA	
Response time	< 0.5	ns	
Varistor voltage temperature coefficient	< 0.05	<b>%/℃</b>	
Capacitance measured at 1MHz	50	pF	Typical
Capacitance tolerance	$\pm 30$	%	
Insulation resistance after reflow soldering on PCB	> 10	MΩ	
Operating ambient temperature	-55 to +125	°C	
Storage temperature	-55 to +125	°C	

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### 1-3 Reliability testing procedures

Reliability parameter	Test	Test methods and remarks	Test requirement
Pulse current capability	<b>Imax</b> 8/20 μs	IEC 1051-1, Test 4.5. 10 pulses in the same direction at 2 pulses per minute at maximum peak current	d   Vn   /Vn ≤ 10% no visible damage
Electrostatic discharge capability	ESD C=150 pF, R=330 Ω	IEC 1000-4-2 Each 10 times in positive/negative direction in 10 sec at 8KV contact discharge (Level 4)	d│Vn│/Vn≤10% no visible damage
Step 1 : Min Step 2 : Max		IEC 68-2-14   Condition for 1 cycle   Step 1 : Min40°C, 30±3 min.   Step 2 : Max. +125°C, 30±3 min.   Number of cycles: 30 times	d   Vn   /Vn ≤ 5% no visible damage
	Low temperature	$\frac{ \text{EC 68-2-1} }{\text{Place the chip at -40 \pm 5 }^{\circ} \text{C for 1000 \pm 12 hrs. Remove and place for 24 \pm 2 hrs at room temp. condition, then measure}$	d   Vn   /Vn≤5% no visible damage
	High temperature	<u>IEC 68-2-2</u> Place the chip at $125\pm5^{\circ}$ for $1000\pm$ 24hrs. Remove and place for $24\pm2$ hrs at room temp. condition, then measure	d   Vn   /Vn≤5% no visible damage
	Heat resistance	<u>IEC 68-2-3</u> Apply the rated voltage for $1000\pm48$ hrs at $85\pm3$ °C. Remove and place for $24\pm$ 2hrs at room temp. condition, then measure	d   Vn  /Vn ≤5% no visible damage
	Humidity resistance	<u>IEC 68-2-30</u> Place the chip at $40\pm2$ °C and 90 to 95% humidity for $1000\pm24$ hrs. Remove and place for $24\pm2$ hrs at room temp. condition, then measure	d│Vn│/Vn≤10% no visible damage
	Pressure cooker test	Place the chip at 2 atm, $120^{\circ}C$ , $85\%$ RH for 60 hrs. Remove and place for $24 \pm$ 2hrs at room temp. condition, then measure	d   Vn   /Vn ≤ 10% no visible damage
	Operating life	Apply the rated voltage for $1000 \pm 48$ hrs at $125 \pm 3$ °C. Remove and place for $24 \pm$ 2hrs at room temp. condition, then measure	d   Vn   /Vn ≤ 10% no visible damage

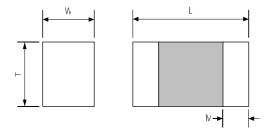
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Mechanical Reliability	Solderability	<u>IEC 68-2-58</u> Solder bath method, 230±5℃, 2s	At least 95% of terminal electrode is covered by new solder
	Resistance to	IEC 68-2-58	d Vn /Vn≤5%
	soldering heat	Solder bath method, 260±5℃, 10±0.5s, 270±5℃, 3±0.5s	no visible damage
	Bending strength	IEC 68-2-21	d   Vn   /Vn≤5%
		Warp:2mm, Speed:0.5mm/sec, Duration: 10sec. The measurement shall be made with board in the bent position	no visible damage
	Adhesive strength	IEC 68-2-22	Strength>10 N
		Applied force on SMD chip by fracture from PCB	no visible damage

## 2. Material Specification

Body	ZnO based ceramics
Internal electrode	Silver – Palladium
External electrode	Silver – Nickel – Tin
Thickness of Ni/Sn plating layer	Nickel > 1 $\mu$ m, Tin > 2 $\mu$ m

## 3. Dimension Specification



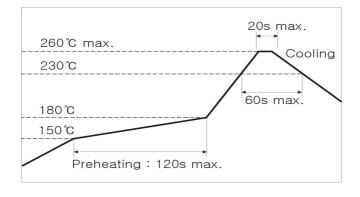
Size	L(mm)	W(mm)	T(mm)	M(mm)
0402	$1.0 \pm 0.10$	$0.5 \pm 0.10$	≤ 0.6	$0.20 \pm 0.10$
0603	1.6±0.15	0.8±0.15	≤ 0.9	$0.35 \pm 0.10$

## 4. Soldering Recommendations

#### 4-1 Soldering profile

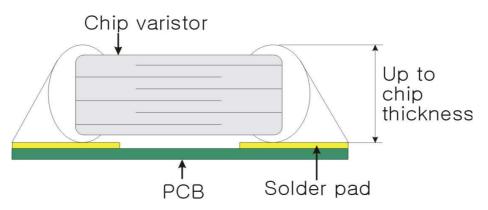


4-1-1 Pb free solder paste



#### 4-1-2 Repair soldering

- Allowable time and temperature for making correction with a soldering iron
  - : 350  $\pm$  10  $^\circ \!\!\! \mathbb{C}$ , 3 sec.
- Optimum solder amount when corrections are made using a soldering iron

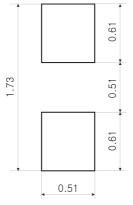


#### 4-2 Soldering guidelines

- Our chip varistors are designed for reflow soldering only. Do not use flow soldering
- Use non-activated flux (CI content 0.2% max.)
- Follow the recommended soldering conditions to avoid varistor damage.

#### 4-3 Solder pad layout





### 5. Storage condition

- Chip varistors can experience degradation of termination solderability when subjected to high temperature of humidity, or if exposed to sulfur or chlorine gases.
- Avoid mechanical shock (ex. Falling) to the chip varistor to prevent mechanical cracking inside of the ceramic dielectric due to its own weight.
- Use chips within 6 months.

If 6 months of more have elapsed, check solderability before use.-

## 6. Description about package label

#### Type : MVR0603-180E500

MVR: Series name 0603 : Chip size –0603 (1.6 x 0.8 mm) size 180 : Maximum continuous working voltage – 18Vdc E : Product function – E for ESD 500 : Capacitance value – means 50pF

#### Qunatity : 4,000 pcs

- Quantity of shipping chip varistor